

Investigation of the atomic and electronic structure of the van der Waals heterostructure MoSe₂-graphene

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In the route to novel functionalities of two-dimensional (2D) materials, three-dimensional entities conceptualized from 2D-lego pieces have drawn particular attention because of the dimensionality effect and exotic properties [1,2]. As 2D layers are held together by a van der Waals (vdW) force, vertical heterostructures based on these layers are a genuine approach which offers a fertile platform to study fascinating van der Waals-driven properties: commensurate lattice coincidence, electronic structure and band structure line-up, spin-orbit coupling induced by proximity effect and by inversion symmetry breaking.

In this poster, we report on the synthesis and characterization of the van der Waals heterostructure: MoSe₂/free-standing-graphene by molecular beam epitaxy. This fabrication approach consists of depositing MoSe₂ on graphitized graphene-SiC substrate, leading to a pure vdW interface. This enables to study properly the intrinsic properties as well as vdW-type interactions in this 2D system. We employed surface-sensitive techniques in order to probe structural and electronic properties of the heterostructure ranging from atomic resolution (STM-STS) to microscopic scale (synchrotron diffraction, ARPES). At the atomic standpoint, the STM shows point

defects and twin boundaries in the MoSe₂ layer. This kind of defects is in general observed in MBE-2D layers due to Se vacancies and domain merging. STS measurement at selected point on MoSe₂ layer indicates a band gap of 2.1 eV separating the valence band maximum and conduction band minimum. Regarding the microscopic scale measurements, we found that the crystallographic directions of the MoSe₂ lattice align perfectly along the ones of graphene, resulting in only one commensurate configuration. This structural analysis by synchrotron diffraction is well consistent with the constant energy map in k-space of the electronic band structures of MoSe₂-graphene probed by ARPES. We observe a clear evolution of the band structure of the graphene-heterostructure compared to the one of bare graphene, which is a direct consequence of the interlayer coupling between the MoSe₂ layer and graphene. Finally, substrate-induced interactions will be also discussed by comparing the resulting data with the MBE-MoSe₂/graphene grown by chemical vapour deposition on Pt/SiO₂/Si substrate.

References

- [1] G. R. Bhimanapati, *et al.* ACS Nano, 9, 11509 (2015)
- [2] Y. Lui, *et al.*, Nat. Rev. Mater. 1, 16042 (2016)

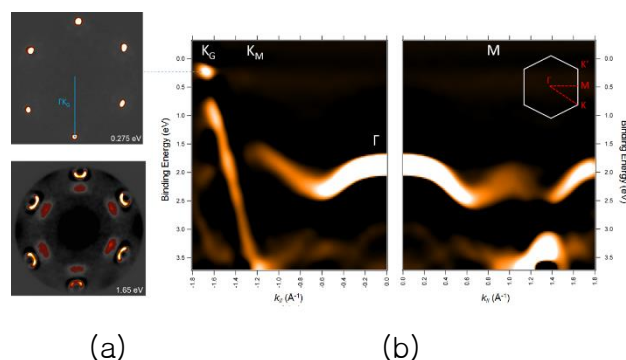


Figure 1: ARPES constant energy maps (a) and band structure (b) of MoSe₂-Graphene viewed along the K-Γ-M direction of MoSe₂